imall

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1200V, 50A, $V_{ce(on)}$ = 2.5V Typical

Ultra Fast NPT - IGBT®

The Ultra Fast NPT - IGBT[®] family of products is the newest generation of planar IGBTs optimized for outstanding ruggedness and the best trade-off between conduction and switching losses.

Features

- Low Saturation Voltage
- Low Tail Current
- RoHS Compliant *M*

- Short Circuit Withstand Rated
- High Frequency Switching
- Ultra Low Leakage Current



ISOTOP[®] Combi (IGBT and Diode)



Unless stated otherwise, Microsemi discrete IGBTs contain a single IGBT die. This device is recommended for applications such as induction heating (IH), motor control, general purpose inverters and uninterruptible power supplies (UPS).

MAXIMUM RATINGS

All Ratings: $T_c = 25^{\circ}C$ unless otherwise specified.

Symbol	Parameter	Ratings	Unit
V _{ces}	Collector Emitter Voltage	1200	V
V_{GE}	Gate-Emitter Voltage	±30	v
I _{C1}	Continuous Collector Current @ T_c = 25°C	84	
I _{C2}	Continuous Collector Current @ T _c = 90°C	50	А
I _{CM}	Pulsed Collector Current ①	200	
SCWT	Short Circuit Withstand Time: V_{ce} = 600V, V_{ge} = 15V, T_c = 125°C	10	μs
P _D	Total Power Dissipation @ T_c = 25°C	417	W
T_,T _{stg}	Operating and Storage Junction Temperature Range	-55 to 150	
TL	Max. Lead Temp. for Soldering: 0.063" from Case for 10 Sec.	300	°C

STATIC ELECTRICAL CHARACTERISTICS

Symbol	Parameter	Min	Тур	Мах	Unit
V _{(BR)CES}	Collector-Emitter Breakdown Voltage ($V_{GE} = 0V, I_{c} = 1.1mA$)	1200			
V _{GE(TH)}	Gate Threshold Voltage ($V_{CE} = V_{GE}$, $I_{C} = 2.5$ mA, $T_{j} = 25^{\circ}$ C)	3.5	5.0	6.5	
V _{CE(ON)}	Collector-Emitter On Voltage (V_{GE} = 15V, I_{C} = 50A, T_{j} = 25°C)	Î	2.5	3.2	Volts
	Collector-Emitter On Voltage (V_{GE} = 15V, I_{C} = 50A, T_{j} = 125°C)		3.3		1
	Collector-Emitter On Voltage (V_{GE} = 15V, I _c = 100A, T _j = 25°C)		3.5		
I _{CES}	Collector Cut-off Current (V _{CE} = 1200V, V _{GE} = 0V, T _j = 25°C) ⁽²⁾		20	1100	μA
	Collector Cut-off Current (V _{CE} = 1200V, V _{GE} = 0V, T _j = 125°C) ⁽²⁾		200		
I _{GES}	Gate-Emitter Leakage Current (V _{GE} = ±20V)			±250	nA

CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

DYNAMIC CHARACTERISTICS

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
C _{ies}	Input Capacitance	Capacitance	ĺ	5550	Ì	
C _{oes}	Output Capacitance	V _{GE} = 0V, V _{CE} = 25V		500		рF
C _{res}	Reverse Transfer Capacitance	f = 1MHz		145		
V _{GEP}	Gate to Emitter Plateau Voltage			7.5		V
Q _g 3	Total Gate Charge	Gate Charge		330	445	
Q _{ge}	Gate-Emitter Charge	$V_{GE} = 15V$		52	72	
Q _{gc}	Gate- Collector Charge	V _{CE} = 600V I _C = 50A		156	200	nC
t _{d(on)}	Turn-On Delay Time	Inductive Switching (25°C)		28		
t _r	Current Rise Time	V _{cc} = 600V		38	Ì	
t _{d(off)}	Turn-Off Delay Time	V _{GE} = 15V		237	Î	ns
t _r	Current Fall Time	I _c = 50A		45		
E _{on2} 5	Turn-On Switching Energy	$R_{g} = 4.3 \ \Omega^{(4)}$		2135	3200	
E _{off}	Turn-Off Switching Energy	T _J = +25°C		1478	2210	μJ
t _{d(on)}	Turn-On Delay Time	Inductive Switching (125°C)		28		
t,	Current Rise Time	V _{cc} = 600V		38		
t _{d(off)}	Turn-Off Delay Time	V _{GE} = 15V		270		ns
t _r	Current Fall Time	I _c = 50A		54		
E _{on2} 5	Turn-On Switching Energy	$R_{g} = 4.3 \ \Omega^{(4)}$		3157	4765	
E _{off}	Turn-Off Switching Energy	T_= +125°C		1884	2820	μJ

THERMAL AND MECHANICAL CHARACTERISTICS

Symbol	Characteristic	Min	Тур	Max	Unit	
R _{ejc}	Junction to Case Thermal Resistance (IGBT)			.30		
	Junction to Case Thermal Resistance (Diode)			1.1	°C/W	
Visolation	RMS Voltage (50-60Hz Sinusoidal Waveform From Terminals to Mounting Base for 1 Min.)	2500				
W _T	Package Weight		1.03		oz	
			29.2		g	
Torque	Maximum Mounting Torque			10	lb∙in	
				1.1	N∙m	

1 Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.

2 Pulse test: Pulse Width < $380\mu s$, duty cycle < 2%.

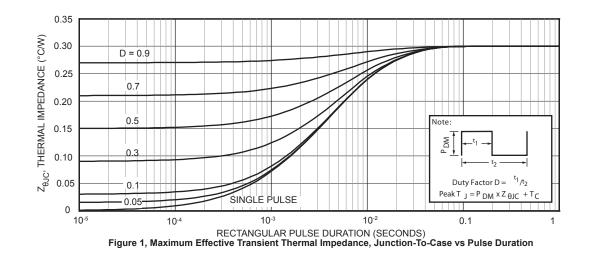
3 See Mil-Std-750 Method 3471.

4 R_G is external gate resistance, not including internal gate resistance or gate driver impedance. (MIC4452)

5 E_{on2} is the energy loss at turn-on and includes the charge stored in the freewheeling diode.

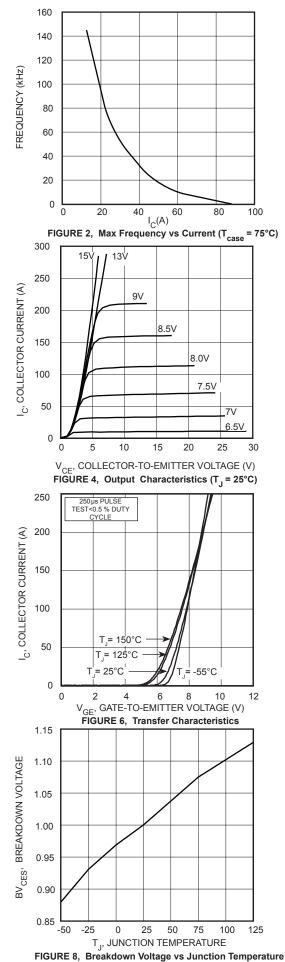
6 E_{off} is the clamped inductive turn-off energy measured in accordance with JEDEC standard JESD24-1.

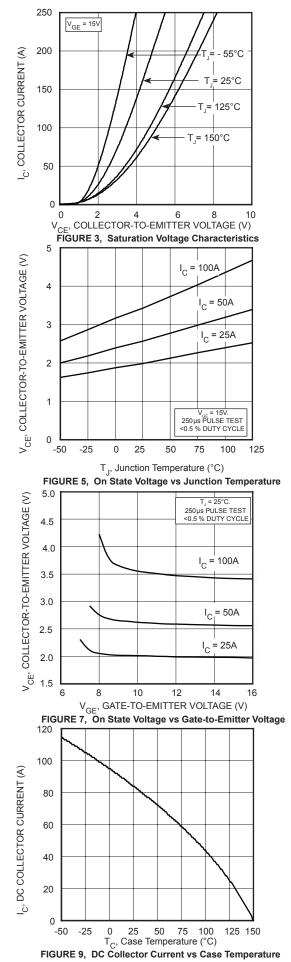
Microsemi reserves the right to change, without notice, the specifications and information contained herein.



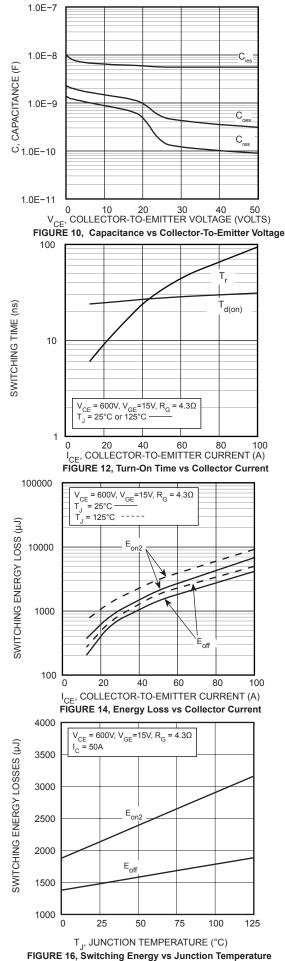
TYPICAL PERFORMANCE CURVES

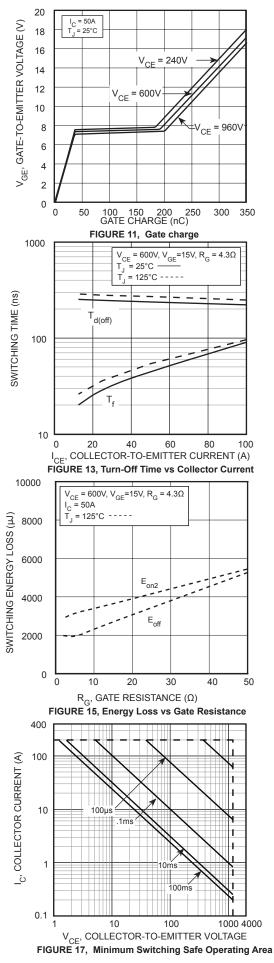
APT50GR120JD30













ULTRAFAST SOFT RECOVERY RECTIFIER DIODE

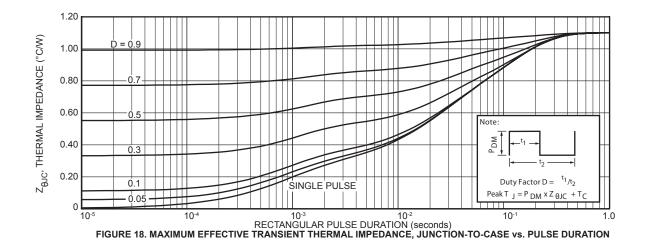
MAXIMUN	I RATINGS All Ratings: 1	All Ratings: T _c = 25°C unless otherwise specified			
Symbol	Characteristic / Test Conditions	APT50GR120JD30			
I _{F(AV)}	Maximum Average Forward Current (T _C = 92°C, Duty Cycle = 0.5)	30			
I _{F(RMS)}	RMS Forward Current (Square wave, 50% duty)	39	Amps		
I _{ESM}	Non-Repetitive Forward Surge Current (T, = 45°C, 8.3 ms)	210			

STATIC ELECTRICAL CHARACTERISTICS

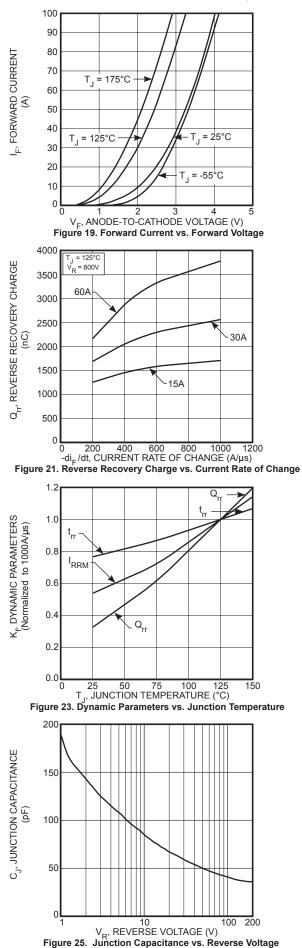
Symbol	Characteristic / Test Conditions		Min	Туре	Max	Unit
V _F	Forward Voltage	I _F = 30A		2.6		
		I _F = 60A		3.25		Volts
		I _F = 30A, T _J = 125°C		1.8		

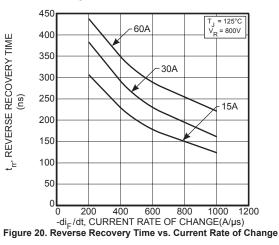
DYNAMIC CHARACTERISTICS

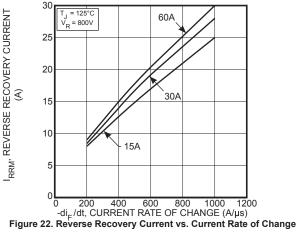
Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
t _{rr}	Reverse Recovery Time	I _F = 1A, di _F /dt = -100A/μs, V _R = 30V, T _J = 25°C	-	25	-	ns
t _{rr}	Reverse Recovery Time	I _F = 30A, di _F /dt = -200A/μs V _R = 800V, T _C = 25°C	-	300	-	
Q _{rr}	Reverse Recovery Charge		-	360	-	nC
I _{RRM}	Maximum Reverse Recovery Current		-	4	-	Amps
t _{rr}	Reverse Recovery Time	I _F = 30A, di _F /dt = -200A/μs V _R = 800V, T _C = 125°C	-	380	-	ns
Q _{rr}	Reverse Recovery Charge		-	1700	-	nC
I _{RRM}	Maximum Reverse Recovery Current		-	8	-	Amps
t _{rr}	Reverse Recovery Time	I _F = 60A, di _F /dt = -1000A/μs V _R = 800V, T _C = 125°C	-	160	-	ns
Q _{rr}	Reverse Recovery Charge		-	2550	-	nC
I _{RRM}	Maximum Reverse Recovery Current		-	28	-	Amps



T_J = 25°C unless otherwise specified







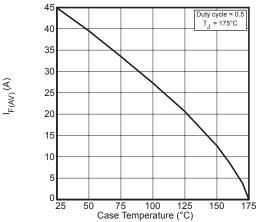


Figure 24. Maximum Average Forward Current vs. CaseTemperature

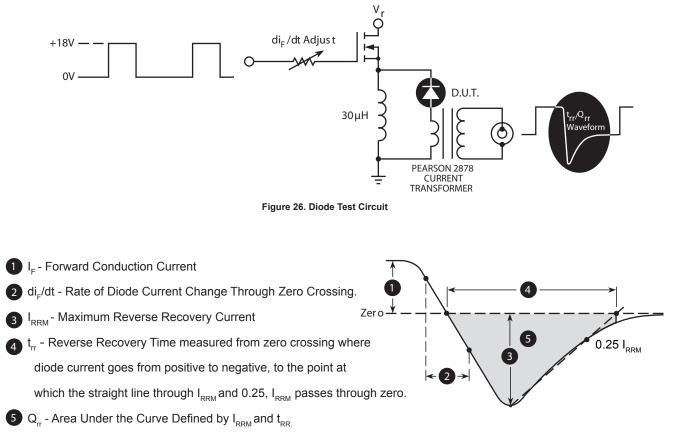
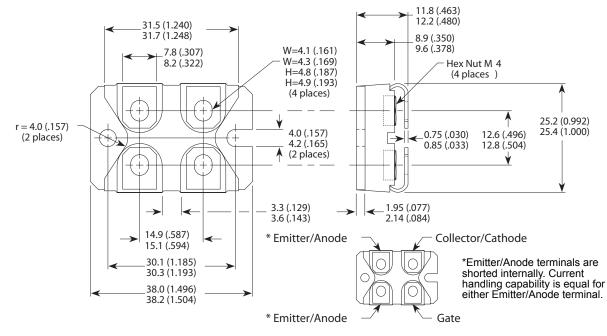


Figure 27. Diode Reverse Recovery Waveform Definition



SOT-227 (ISOTOP®) Package Outline

Dimensions in Millimeters and (Inches)

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